Application/Control No. 10/670,245	Reexamination	Applicant(s)/Patent Under Reexamination SUGANO ET AL.		
Examiner	Art Unit			
JESSICA PRINCE	2495	Page 1 of 1		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,801,765 A	09-1998	Gotoh et al.	348/155
*	В	US-2001/0051516 A1	12-2001	Nakamura et al.	455/412
*	O	US-6,347,114 B1	02-2002	Blanchard, Simon	375/240
*	D	US-6,392,710 B1	05-2002	Gonsalves et al.	348/578
*	Е	US-2002/0080162 A1	06-2002	Pan et al.	345/723
*	F	US-6,549,643 B1	04-2003	Toklu et al.	382/107
*	G	US-6,597,738 B1	07-2003	Park et al.	375/240.16
*	н	US-7,110,454 B1	09-2006	Chakraborty, Amit	375/240.16
	-	US-			
	7	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
*	U	Yimaz, Alper; Shot Detection Using Principal Coordinate System (2000), 2000 pg. 1-6			
	v				
	w				
	х				

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.